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X-ray micro-computed tomography (μ CT) uses high-energy X-rays to non-destructively generate 3D representations of a material with micron/nanometer precision, taking advantage of various contrast mechanisms to enable the quantification of the types and number of inhomogeneities.

Here, members of PARADIM's in-house research team collaborated with external users and summer school participants on case studies of μ CT informing materials design of electronic and quantum materials, benefitting the characterization of inclusions, twinning, and low-angle grain boundaries and optimizing crystal growth processes. The work discusses recent improvements in μ CT instrumentation that enable elemental analysis and orientation to be obtained on crystalline samples, for example the PARADIM User-pioneered electronic materials rutile germanium dioxide (GeO_2 , depicted here).

The benefits of μ CT as a non-destructive tool to analyze bulk samples should encourage the community to adapt this technology into everyday use for electronic and quantum materials discovery.

L.A. Pressley, *et al.* [npj Quantum Materials 7, 121 \(2022\)](#).

Associated data: [10.34863/sd37-3694](https://doi.org/10.34863/sd37-3694).

